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Phys. Rev. B **99**, 195438 — Published 21 May 2019

DOI: [10.1103/PhysRevB.99.195438](https://doi.org/10.1103/PhysRevB.99.195438)

# Interlayer Charge Transfer in ReS<sub>2</sub>/WS<sub>2</sub> van der Waals Heterostructures

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(Dated: May 9, 2019)

We observed ultrafast charge transfer between distorted-1T-ReS<sub>2</sub> with anisotropic in-plane electronic and optical properties and 2H-WS<sub>2</sub> that is in-plane isotropic. Heterostructures of monolayer ReS<sub>2</sub>/monolayer WS<sub>2</sub> and bilayer ReS<sub>2</sub>/monolayer WS<sub>2</sub> were fabricated by mechanical exfoliation and dry transfer techniques. Significant photoluminescence quenching of WS<sub>2</sub> in the heterostructures indicates efficient charge transfer. In femtosecond transient absorption measurements, it was found that holes injected in monolayer or bilayer ReS<sub>2</sub> transfer to WS<sub>2</sub> on a time scale shorter than time resolution of the measurement. This observation provides evidence that the holes are delocalized in bilayer ReS<sub>2</sub>, revealing strong van der Waals interlayer couplings. These results also show that ReS<sub>2</sub> and WS<sub>2</sub> form type-II heterostructures with excellent charge transfer properties.

## I. INTRODUCTION

Since 2010, two-dimensional (2D) transition metal dichalcogenides (TMDs) have been a focus of material research due to their interesting electronic, optical, and spin properties<sup>1-3</sup>. Although most initial efforts have been devoted to a few materials, namely MoS<sub>2</sub>, WS<sub>2</sub>, MoSe<sub>2</sub>, and WSe<sub>2</sub><sup>4</sup>, other members of the TMD family have gain significant momentum recently, especially those possessing different and complementary properties. Rhenium disulfide is such a member with several interesting properties. Unlike most TMDs with stable hexagonal phases, ReS<sub>2</sub> forms a distorted 1*T* structure with triclinic symmetry<sup>5-7</sup>. The lower lattice symmetry gives rise to in-plane anisotropic lattice, electronic, and optical properties, which have been confirmed by optical<sup>8-12</sup> and transport measurements<sup>13-15</sup>. In addition to the exfoliation method used in early studies, techniques to synthesize large-area and high-quality ReS<sub>2</sub> monolayer or thin films have been developed, such as epitaxy<sup>16,17</sup> and chemical vapor deposition<sup>18,19</sup>. Application of ReS<sub>2</sub> in various devices, such as transistors<sup>20-24</sup>, logic gates<sup>21</sup>, and polarization-sensitive photodetectors<sup>20,22,25</sup> have also been explored.

Despite of these progresses, some of the fundamental issues of this elusive material are still under debate. Most pressing ones include the nature of the lowest bandgap and the strength of the interlayer coupling. On the bandgap, early studies have indicated that bulk ReS<sub>2</sub> has a direct bandgap of about 1.5 eV at room temperature<sup>5,26-29</sup>. However, an indirect bandgap of 1.47 eV has been reported<sup>30</sup>. Low photoluminescence (PL) quantum yield generally observed in all thickness appear to suggest that ReS<sub>2</sub> is indirect semiconductor<sup>31</sup>, while *k*-space photoemission microscopy revealed a direct bandgap in the bilayer (2L) ReS<sub>2</sub><sup>32</sup>. On the second issue, early experimental and first-principle studies have suggested that the interlayer coupling in ReS<sub>2</sub> is much weaker than other TMDs<sup>5</sup>. This suggests that the adjacent 1Ls in bulk ReS<sub>2</sub> are largely electronically decoupled with the electrons localized in each layers. The extremely weak van der Waals coupling in vertical ReS<sub>2</sub> nanowalls is recently utilized for high-current-density Li-ion batteries<sup>33</sup>. However, several evidences have been later reported that suggest rather strong interlayer coupling. First, optical absorption and PL measurements showed that the room-temperature optical bandgap evolves gradually from 1.47 eV in bulk to 1.61 eV in 1L<sup>10</sup>. Second, interlayer phonon modes were observed in Raman measurements, indicating that the ReS<sub>2</sub> layers are coupled and orderly stacked<sup>34,35</sup>. The interlayer force constants were about 55 - 90 % of those of multilayer MoS<sub>2</sub><sup>36</sup>. Third, photoemission microscopic measurements showed that the valence electrons in bulk ReS<sub>2</sub> are delocalized across the layers and the valence band dispersion evolves with the thickness<sup>32</sup>. In addition, qualitatively different charge transport characteristics between 1L and multilayers<sup>37</sup> appear to suggest thickness-dependent bandstructures.

Here we report direct evidence of electron interlayer delocalization in 2L ReS<sub>2</sub> by comparing charge transfer in 1L-ReS<sub>2</sub>/1L-WS<sub>2</sub> and 2L-ReS<sub>2</sub>/1L-WS<sub>2</sub> heterostructures fabricated by mechanical exfoliation and dry transfer. Interlayer charge transfer between 2D materials<sup>38-44</sup> plays a key role in forming 2D heterostructures with emergent properties. Therefore, study of charge transfer between ReS<sub>2</sub> and other TMDs is an important step towards introducing ReS<sub>2</sub> to the material library for constructing 2D heterostructures. Interestingly, recent studies have revealed that ReS<sub>2</sub> can form type-I band alignment with MoS<sub>2</sub><sup>45</sup>, type-II band alignment with WSe<sub>2</sub><sup>46</sup>, and type-III broken-gap alignment with black phosphorus<sup>47</sup>, illustrating the flexibility of band alignment design ReS<sub>2</sub> can provide. However, despite of the recent progress on their growth<sup>48</sup> and device applications<sup>46,49</sup>, the charge transfer process in ReS<sub>2</sub>-based heterostructures is still yet to be studied. In this study by transient absorption and steady-state PL measurements, we found that holes optically injected in ReS<sub>2</sub> transfer to WS<sub>2</sub> on a sub-100 fs time scale, and the transfer from 2L ReS<sub>2</sub> appears to be even faster. This observation suggests that the holes in 2L ReS<sub>2</sub> are not localized in each ReS<sub>2</sub> layer, and thus provide direct evidence of electronic delocalization in this material. Furthermore, the ultrafast charge transfer between Re<sub>2</sub> and WS<sub>2</sub> is encouraging news for developing van der Waals heterostructures using ReS<sub>2</sub>.

## II. SAMPLE FABRICATION AND PHOTOLUMINESCENCE

Figure 1(a) shows the fabricated sample. First, a ReS<sub>2</sub> flake containing 1L and 2L regions was mechanically exfoliated on a polydimethylsiloxane (PDMS) substrate. Since the substrate (about 1 mm) is much thicker than the ReS<sub>2</sub> flake and is transparent, the optical contrast of the flake is proportional to its thickness<sup>11,51-54</sup>. By investigating a large number of thin flakes, we establish that the contrast of 1L is about 15.5%. Next, the selected ReS<sub>2</sub> flake was transferred to a Si/SiO<sub>2</sub> (90 nm) substrate. A 1L WS<sub>2</sub> fabricated and identified with the same procedure was then transferred on top of the ReS<sub>2</sub> flake such that it covers parts of both 1L and 2L ReS<sub>2</sub> regions as well as the substrate. Hence, the same sample contains heterostructure regions of 1L-ReS<sub>2</sub>/1L-WS<sub>2</sub> and 2L-ReS<sub>2</sub>/1L-WS<sub>2</sub>, as well as a 1L WS<sub>2</sub> region. The sample was annealed for 4 hours at 200°C under 100 sccm of Ar gas environment with a pressure of 2 - 3 Torr. All measurement were done at room temperature with the sample under ambient conditions.

The expected band alignment of the 1L-ReS<sub>2</sub>/1L-WS<sub>2</sub> heterostructure is shown in Figure 1(b). The values shown are adopted from a theoretical study<sup>50</sup>. The conduction band minimum (CBM) and the valence band maximum (VBM) are located in the ReS<sub>2</sub> and WS<sub>2</sub> layers, respectively. Such a type-II band alignment allow charge transfer, *i.e.* electron transfer from WS<sub>2</sub> to ReS<sub>2</sub> and hole transfer along the opposite direction. Since the offsets in the conduction and valence bands of 0.58 and 0.37 eV are much larger than the room-temperature lattice thermal energy of 0.025 eV, thermal excitation is unlikely to affect the direction of charge transfer. We note that although other theoretical works have yielded slightly different values of the band offsets, the

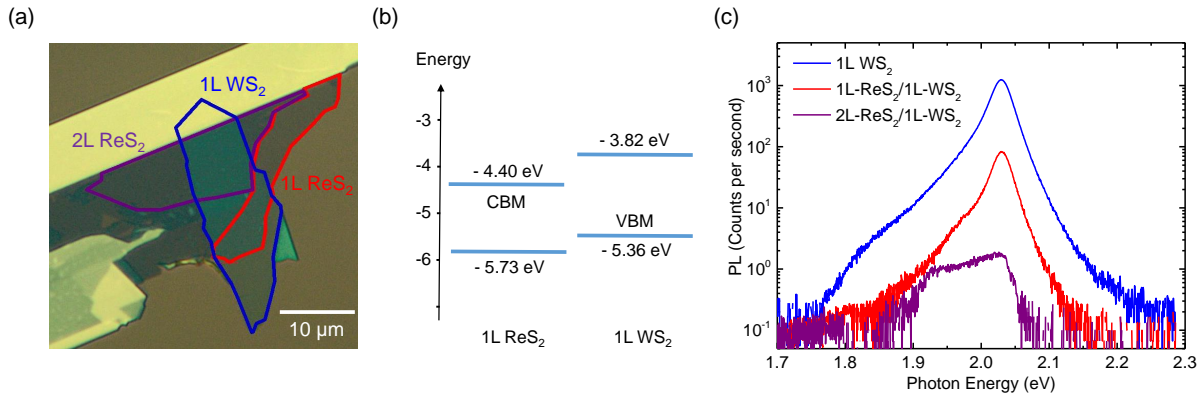


FIG. 1. (a) An optical microscopy image of the sample. (b) Band alignment of 1L-ReS<sub>2</sub>/1L-WS<sub>2</sub> according to theory<sup>50</sup>. (c) PL of 1L WS<sub>2</sub> (blue), 1L-ReS<sub>2</sub>/1L-WS<sub>2</sub> (red), and 2L-ReS<sub>2</sub>/1L-WS<sub>2</sub> (purple).

type-II nature of the alignment has been consistently produced<sup>32,45,55,56</sup>.

Figure 1(c) shows the PL spectra from regions of 1L WS<sub>2</sub> (blue), 1L-ReS<sub>2</sub>/1L-WS<sub>2</sub> (red), and 2L-ReS<sub>2</sub>/1L-WS<sub>2</sub> (purple), respectively. The measurement was performed with a 405-nm continuous-wave laser with a 200-nW power and a focused spot size of about 2 μm. The spectrum of 1L WS<sub>2</sub> peaks at 2.025 eV. The position, quantum yield, and the spectral width of this peak are all in good agreement with previous reported values.<sup>40,57,58</sup> The peak shifts to 2.023 eV in the 1L-ReS<sub>2</sub>/1L-WS<sub>2</sub> heterostructure. The reduction of the optical bandgap of 2 meV can be attributed to the changes of both the bandgap and the exciton binding energy of WS<sub>2</sub> caused by the screening effect of ReS<sub>2</sub><sup>40</sup>. The peak further shifts to 2.021 eV in the 2L-ReS<sub>2</sub>/1L-WS<sub>2</sub> heterostructure, which is consistent with the expected larger screening effect due to the doubled thickness. Furthermore, significant quenching of PL was observed in both heterostructures, suggesting efficient charge or energy transfer from WS<sub>2</sub> to ReS<sub>2</sub> on a time scale shorter than the exciton lifetime in WS<sub>2</sub>. We moved the laser spot on each heterostructure region, and confirmed that the quenching factors of about 15 and 700 in the two regions are reproducible.

It is interesting to note that the spectrum of 2L-ReS<sub>2</sub>/1L-WS<sub>2</sub> heterostructure has a shoulder at the low-energy side, which is absent in the other two regions. Since this shoulder is about 50 meV below the main peak, which is close to the trion binding energy of WS<sub>2</sub>, we attribute this peak to trions, which is confirmed by the dependence of the PL spectrum on the excitation power (See Supplemental Material<sup>59</sup>). We note that this shoulder is also visible in the 1L-ReS<sub>2</sub>/1L-WS<sub>2</sub> region, although it is less pronounced.

### III. TIME-RESOLVED MEASUREMENTS

Charge carrier dynamics was studied by transient absorption measurements in the reflection geometry. In the experimental setup, a Ti:sapphire laser generates 100-fs pulses with a central wavelengths of about 780 - 790 nm, a spectral width of about 10 nm, and a repetition rate of 80 MHz. One part of this beam is sent to a nonlinear optical crystal to generate second harmonic pulses of about 390 - 395 nm. The rest of the beam is used to pump an optical parametric oscillator to produce near infrared pulse in the range of 1220 - 1280 nm, which second harmonic in the range of 610 - 640 nm is close to the optical bandgap of WS<sub>2</sub>. The output of the Ti:sapphire can also be used directly in the experiment. In a certain experimental configuration, two of these pulses are used as the pump and probe, which are combined by a beamsplitter and are focused to the sample from normal direction through a microscope objective lens. The reflected probe beam is sent to a photodetector, which output is measured by a lock-in amplifier. The intensity of the pump beam is modulated by a mechanical chopper at about 3 KHz. With the configuration, the lock-in amplifier measured the differential reflection of the probe as the probe delay (defined as the arrival time of the probe pulse at the sample with respect to the pump pulse) is varied by changing the probe path length. The differential reflection is defined as  $\Delta R/R_0 = (R - R_0)/R_0$ , where  $R$  and  $R_0$  are the probe reflectance with and without the presence of the pump beam, respectively.

We first studies photocarrier dynamics in individual 1L WS<sub>2</sub>, 1L ReS<sub>2</sub>, and 2L ReS<sub>2</sub> regions. For 1L-WS<sub>2</sub>, a 3.18-eV pump pulse with an energy fluence of 3 μJ cm<sup>-2</sup> was used to inject free carriers. Using an absorption coefficient of 7.5×10<sup>7</sup> m<sup>-160</sup>, the estimated peak density of injected electron-hole pairs is about 3×10<sup>11</sup> cm<sup>-2</sup>. The differential reflection measured with a 2.01-eV probe pulse, which is near the optical bandgap of WS<sub>2</sub>, is shown by the blue squares in Figure 2 for short (a) and long (b) time ranges, respectively. The rise of the signal can be fit by the integral of a Gaussian function with a full-width at half-maximum of 0.375 ps, as indicated by the curve in (a). This time is longer than the cross correlation of the pump and probe pulses of about 200 fs, which suggests that the injected free carriers produce maximum signal at the exciton resonance at a slightly delayed time.

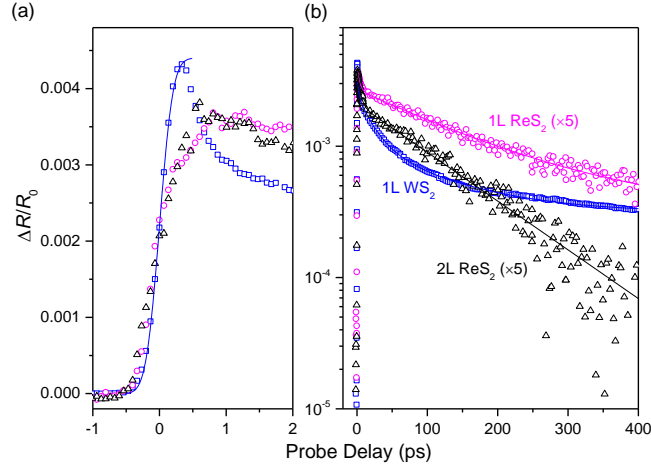


FIG. 2. Differential reflection of individual materials of 1L WS<sub>2</sub> (blue squares), 1L ReS<sub>2</sub> (magenta circles), and 2L ReS<sub>2</sub> (black triangles) over short (a) and long (b) time ranges. Photocarriers are injected by a 3.18-eV pump and detected by probes of 2.01 eV for WS<sub>2</sub> and 1.61 eV for both ReS<sub>2</sub> regions, respectively. The curves are fits (see text).

TABLE I. Summary of the time constants deduced from the exponential fits.

Sample	$\tau_1$ (weight)	$\tau_2$ (weight)	$\tau_3$ (weight)	Background
1L WS <sub>2</sub>	$1.9 \pm 0.3$ ps (31 %)	$22 \pm 3$ ps (39 %)	$115 \pm 30$ ps (21 %)	9 %
1L ReS <sub>2</sub>	$3.6 \pm 0.6$ ps (33 %)	$160 \pm 20$ ps (60 %)	– (0 %)	7 %
2L ReS <sub>2</sub>	$4.1 \pm 0.4$ ps (45 %)	$117 \pm 15$ ps (55 %)	– (0 %)	0 %
1L-ReS <sub>2</sub> /1L-WS <sub>2</sub>	$1.3 \pm 0.2$ ps (15 %)	$330 \pm 50$ ps (7 %)	– (0 %)	78 %
2L ReS <sub>2</sub> /1L-WS <sub>2</sub>	$1.0 \pm 0.2$ ps (50 %)	$46 \pm 5$ ps (14 %)	– (0 %)	36 %

The decay of the signal can be fit by a tri-exponential function,  $\Delta R/R_0(t) = A_1 \exp(-t/\tau_1) + A_2 \exp(-t/\tau_2) + A_3 \exp(-t/\tau_3) + B$ , as shown by the black curve in (b), with the three processes of time constants (and weights) of  $\tau_1$  of  $1.9 \pm 0.3$  ps (31 %),  $\tau_2$  of  $22 \pm 3$  ps (39 %),  $\tau_3$  of  $115 \pm 30$  ps (21 %), and a background of 9 %. Based on previous studies, the  $\tau_1$  process can be related to formation of excitons from free carriers<sup>61,62</sup>, which causes reduction of the signal. However, we note that the time constant observed from this sample is longer than previous studies<sup>61,62</sup>. The attribute the 22-ps process to exciton recombination, which is consistent with previously reported exciton lifetime in 1L WS<sub>2</sub><sup>63</sup>. The rest of the process, which accounts for about 30 % of the signal, could be attributed to effects of lattice heating by the laser pulse or defects. All the time constants are summarized in Table I for better comparison, along with those from the heterostructures.

The magenta and black symbols in Figure 2 show the signal from the 1L and 2L ReS<sub>2</sub> regions, respectively. For clarity, both signals have been multiplied by a factor of 5. In these measurements, the same pump photon energy (3.18 eV) and fluence ( $3 \mu\text{J cm}^{-2}$ ) were used, while the probe was tuned to 1.61 eV, which is about 0.1 eV above the optical bandgap of ReS<sub>2</sub>. With an absorption coefficient of  $3.5 \times 10^7 \text{ m}^{-1}$ ,<sup>26</sup> the pump injects a peak carrier density of  $1.35 \times 10^{11}$  and  $2.7 \times 10^{11} \text{ cm}^{-2}$  in the 1L and 2L ReS<sub>2</sub> regions, respectively. From Figure 2(a), the signals show a slower rise, compared to WS<sub>2</sub>, of about less than 1 ps. Since the pump photon energy is much larger than the bandgap of ReS<sub>2</sub>, the rise could be attributed to energy relaxation of hot carriers from their injected states to the states that are probed. The decay of the signal in both regions can be fit by a biexponential function,  $\Delta R/R_0(t) = A_1 \exp(-t/\tau_1) + A_2 \exp(-t/\tau_2) + B$ . For the 1L, the two time constants are  $\tau_1 = 3.6 \pm 0.6$  ps (33 %) and  $\tau_2 = 160 \pm 20$  ps (60 %), with a background of 7 % (magenta curve). For the 2L, these parameters are  $\tau_1 = 4.1 \pm 0.4$  ps (45 %) and  $\tau_2 = 117 \pm 15$  ps (55 %), with almost no background (black curve). Both the magnitude and the time evolution of the signal from the two ReS<sub>2</sub> regions are similar, suggesting similar carrier dynamics in 1L and 2L ReS<sub>2</sub>. The long time constants can be attributed to exciton lifetime in these samples.

With the information on carrier dynamics in the three individual materials, we next studied charge transfer between them. To probe potential hole transfer from ReS<sub>2</sub> to WS<sub>2</sub>, we used the configuration shown in Figure 3(a). A 1.57-eV pump pulse selectively excites carriers in 1L or 2L ReS<sub>2</sub>. Since the photon energy is smaller than its optical bandgap, the WS-2 layer is not excited. If the VBM of ReS<sub>2</sub> is lower than WS<sub>2</sub>, as theoretically predicted, holes are expected to transfer to WS<sub>2</sub> to lower their potential energy. By using a probe tuned near the optical bandgap of WS<sub>2</sub>, we monitor the appearance of these holes in WS<sub>2</sub> and time resolve their dynamics. Electrons are expected to reside in ReS<sub>2</sub>, which has the lower CBM. The separation of the electrons and holes are expected to allow formation of spatially-indirect excitons with prolonged lifetime<sup>64,65</sup>.

The differential reflection signals obtained with this configuration from the 1L-ReS<sub>2</sub>/1L-WS<sub>2</sub> and 2L-ReS<sub>2</sub>/1L-WS<sub>2</sub> het-

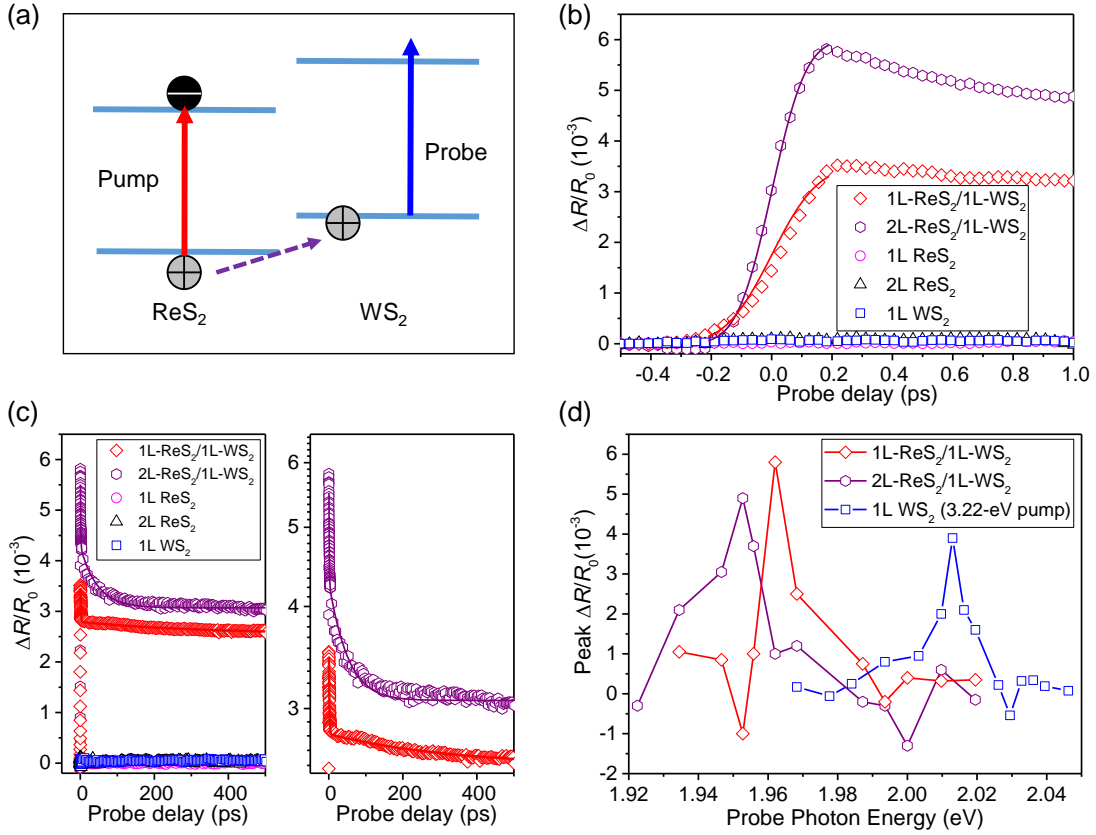


FIG. 3. (a) Schematics of the pump-probe configuration to study hole transfer from ReS<sub>2</sub> to WS<sub>2</sub>. (b) Differential reflection signal obtained from the heterostructures of 1L-ReS<sub>2</sub>/1L-WS<sub>2</sub> (red diamonds) and 2L-ReS<sub>2</sub>/1L-WS<sub>2</sub> (purple hexagons) using the configuration shown in (a). Results of the same measurements on regions of 1L WS<sub>2</sub> (blue squares), 1L ReS<sub>2</sub> (magenta circles), and 2L ReS<sub>2</sub> (black triangles) are also shown for comparison. (c) Same as (b) but with a longer time range and with linear (left) and logarithmic scales. (d) Peak differential reflection signal as a function of the probe photon energy for the two heterostructures and the 1L WS<sub>2</sub>

eroheterostructures are shown by the red diamonds and purple hexagons in Figure 3(b) and (c) for short and long time ranges, respectively. In these measurements, the pump injects carrier densities of  $4.1 \times 10^{11}$  and  $8.2 \times 10^{11}$  cm<sup>-2</sup> in 1L and 2L ReS<sub>2</sub>, respectively. The probe photon energies used are 1.97 and 1.95 eV for 1L-Re<sub>2</sub>/1L-WS<sub>2</sub> and 2L-ReS<sub>2</sub>/1L-WS<sub>2</sub> heterostructures, respectively. The rather strong signal observed suggests the occurrence of hole transfer. We next studied the dependence of the signal magnitude on the probe photon energy for the two heterostructure samples. As shown in Figure 3(d), both heterostructures show pronounced resonant feature near the A-exciton of WS<sub>2</sub> that is consistent with PL peaks shown in Figure 1(c). For comparison, probe-photon-energy dependence of the 1L WS<sub>2</sub> sample was also plotted, which was obtained by using a pump pulse of 3.18 eV. These differential reflection spectra show that the signal indeed originates from the change of the excitonic resonance of WS<sub>2</sub>, instead of from higher energy states in ReS<sub>2</sub>. To further confirm the origin of the signal, we repeated the measurement on the three regions of the individual materials. No signal was observed, as shown by the magenta circles (1L ReS<sub>2</sub>), black triangles (2L ReS<sub>2</sub>), and blue squares (1L WS<sub>2</sub>). This is expected, since for the 1L WS<sub>2</sub> region the pump does not inject carriers while for the ReS<sub>2</sub> regions the probe is far away from their optical bandgaps and thus has low probing efficiency.

Having established the hole transfer process, we now compare the two heterostructures. First, the red diamonds in Figure 3(b) show that the signal in 1L-ReS<sub>2</sub>/1L-WS<sub>2</sub> rises to its peak rapidly. The red curve over the data represents the integral of a Gaussian function with a full-width at half-maximum of 280 fs, showing the ultrafast nature of the hole transfer process. Interestingly, for 2L-ReS<sub>2</sub>/1L-WS<sub>2</sub>, the rising time corresponds to a width of 220 fs, as shown as the purple circles and curve in Figure 3(b), which suggests that hole transfer from 2L ReS<sub>2</sub> to WS<sub>2</sub> is faster than from 1L ReS<sub>2</sub> to WS<sub>2</sub>. If the two ReS<sub>2</sub> layers are decoupled with electrons localized in each layer, one would expect that the transfer from 2L to be slower with an additional transfer step between the two ReS<sub>2</sub> layers. Hence, we conclude the two ReS<sub>2</sub> layers are coupled and the holes are delocalized.

To analyze the carrier dynamics, we fit the decay process of the signal from the 1L-ReS<sub>2</sub>/1L-WS<sub>2</sub> heterostructure with a bi-exponential function,  $\Delta R/R_0(t) = A_1 \exp(-t/\tau_1) + A_2 \exp(-t/\tau_2) + B$ . The results are plotted as the red curve over the data in Figure 3(c), with parameters of  $A_1 = 0.5 \times 10^{-3}$ ,  $A_2 = 0.24 \times 10^{-3}$ ,  $B = 2.6 \times 10^{-3}$ ,  $\tau_1 = 1.3 \pm 0.2$  ps, and  $\tau_2 = 330 \pm 50$  ps. The fast process of picosecond has been similarly observed in TMD monolayers, and was attributed to exciton formation

of free electron-hole pairs<sup>61,62</sup>, which lowers the effectiveness of carriers in changing the exciton resonance. Here, we assign this process to the formation of interlayer excitons between the transferred holes in WS<sub>2</sub> and the electrons in ReS<sub>2</sub>. The most significant feature observed is the long-lived signal that accounts for a large portion (about 80 %) of the total signal. This suggests that indirect excitons formed after holes transfer have a very long lifetime, which is reasonable considering the spatial separation of electrons and holes. This observation further confirms the type-II nature of the band alignment between 1L ReS<sub>2</sub> and 1L WS<sub>2</sub>. We note that such long-lived and pronounced signal was not observed in the individual materials (see Figure 2). The intermediate  $\tau_2$  process accounts only for a few percent of the signal. This process could be due to various aspects of the dynamics of the indirect excitons following their formation, such as thermalization, energy relaxation, and multi-exciton annihilation. More studies are necessary for fully understanding this process. However, given that this process makes a minor (7%) contribution to the signal, the uncertainty of its nature does not influence the main conclusion of this study. The signal from 2L-ReS<sub>2</sub>/1L-WS<sub>2</sub> (purple hexagons) is similar to 1L-ReS<sub>2</sub>/1L-WS<sub>2</sub>. By using the same bi-exponential function (purple curve over the data), we find the parameter of  $A_1 = 4.4 \times 10^{-3}$ ,  $A_2 = 1.2 \times 10^{-3}$ ,  $B = 3.1 \times 10^{-3}$ ,  $\tau_1 = 1.0 \pm 0.2$  ps, and  $\tau_2 = 46 \pm 5$  ps. Similarly, indirect excitons have a very long lifetime. We note that unlike the 1L WS<sub>2</sub> sample, no effect from lattice heating was observed here, due to the dominant signal from indirect excitons.

#### IV. CONCLUSION

We have observed interlayer charge transfer in heterostructures of 1L-ReS<sub>2</sub>/1L-WS<sub>2</sub> and 2L-ReS<sub>2</sub>/1L-WS<sub>2</sub> by femtosecond transient absorption measurements. In the former heterostructure, holes injected in ReS<sub>2</sub> transfer to WS<sub>2</sub> on an ultrafast time scale, which is encouraging news for incorporating ReS<sub>2</sub> to the material library for fabricating van der Waals heterostructure. The hole transfer from 2L ReS<sub>2</sub> to WS<sub>2</sub> was found to be even faster. If the holes in 2L ReS<sub>2</sub> were localized in each layer, the transfer would require an additional step of interlayer transfer within ReS<sub>2</sub> and thus would have been slower. Hence, this observation is evidence that the holes are delocalized, illustrating the strong interlayer coupling in ReS<sub>2</sub>. The difference in the charge transfer time could be attributed to the different bandstructures in 1L and 2L ReS<sub>2</sub>. These results show that the band alignment of both heterostructures is type II, which is consistent with theoretical predictions.

#### V. ACKNOWLEDGMENT

We are grateful for the financial support of the National Key R&D Program of China (2016 YFA0202302), the National Natural Science Foundation of China (61527817, 61875236), and National Science Foundation of USA (DMR-1505852).

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